

Notice of References Cited	Application/Control No. 10/804,971	Applicant(s)/Patent Under Reexamination YEH, JEN-REN	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,493,376 A	05-1924	CHARLES NELSON	220/620
*	B	US-2,598,962 A	06-1952	MARIE ANSEELE	220/616
*	C	US-3,302,825 A	02-1967	ROBERT SCHLEEWEISS	220/611
*	D	US-3,800,994 A	04-1974	Bowen et al.	229/117.29
*	E	US-4,664,285 A	05-1987	Korcz et al.	220/613
*	F	US-5,697,514 A	12-1997	Hekal, Ihab	220/359.1
*	G	US-6,165,115 A	12-2000	Rea, Keith Robert	493/109
*	H	US-2003/0102315 A1	06-2003	Cheng et al.	220/485
*	I	US-2003/0136786 A1	07-2003	Cheng et al.	220/485
*	J	US-6,718,635 B2	04-2004	Cheng et al.	29/896.6
*	K	US-2005/0077299 A1	04-2005	Cheng et al.	220/485
*	L	US-D526,754 S	08-2006	Hardy et al.	D32/37
*	M	US-D530,517 S	10-2006	Hardy et al.	D3/306

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-D267,395 S	12-1982	Groenewold et al.	D9/425
*	B	US-D298,403 S	11-1988	Hagberg et al.	D7/388
*	C	US-D373,039 S	08-1996	Cohen et al.	D6/566
*	D	US-D419,302 S	01-2000	Hardy et al.	D3/306
*	E	US-D431,907 S	10-2000	Andujar et al.	D3/306
*	F	US-D433,709 S	11-2000	Hardy, Christopher	D19/75
*	G	US-D434,074 S	11-2000	Hardy, Christopher	D19/75
*	H	US-D437,984 S	02-2001	Weiss et al.	D34/1
*	I	US-D449,074 S	10-2001	Andujar, Mina	D19/75
*	J	US-D450,453 S	11-2001	Andujar, Mina	D3/306
*	K	US-D450,481 S	11-2001	Post, R. Neal	D6/465
*	L	US-D451,675 S	12-2001	Hardy et al.	D3/306
*	M	US-D453,027 S	01-2002	Andujar, Mina	D19/90

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
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